## Application/Control No. Applicant(s)/Patent Under Reexamination 10/631,384 PLASS ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2826 A. Sefer **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0048429 03-2004 Baur et al. 438/200 US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS

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